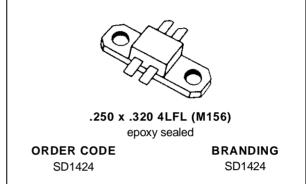
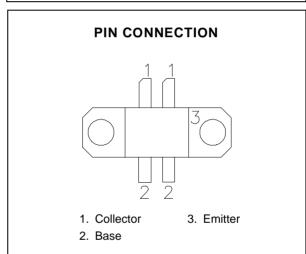


SD1424

RF & MICROWAVE TRANSISTORS 800-900 MHz BASE STATION APPLICATIONS

- 800 900 MHz
- 24 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- CLASS AB LINEAR OPERATION
- Pout = 30 W MIN. WITH 7.5 dB GAIN





DESCRIPTION

The SD1424 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in cellular base station application.

ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

Symbol Parameter Value VCBO Collector-Base Voltage 48 VCES Collector-Emitter Voltage 45 VEBO Emitter-Base Voltage 4.0 IC Device Current 4 PDISS Power Dissipation 87.5 TJ Junction Temperature +200 TSTG Storage Temperature - 65 to +150	,					
VCES Collector-Emitter Voltage 45 VEBO Emitter-Base Voltage 4.0 IC Device Current 4 PDISS Power Dissipation 87.5 TJ Junction Temperature +200	Symbol	Parameter	Value	Unit		
VEBO Emitter-Base Voltage 4.0 IC Device Current 4 PDISS Power Dissipation 87.5 TJ Junction Temperature +200	Vсво	Collector-Base Voltage	48	V		
I _C Device Current 4 P _{DISS} Power Dissipation 87.5 T _J Junction Temperature +200	Vces	Collector-Emitter Voltage	45	V		
P _{DISS} Power Dissipation 87.5 T _J Junction Temperature +200	V _{EBO}	BO Emitter-Base Voltage		V		
T _J Junction Temperature +200	Ic	Device Current	4	Α		
	P _{DISS}	P _{DISS} Power Dissipation		W		
T _{STG} Storage Temperature – 65 to +150	TJ	T _J Junction Temperature		°C		
5.5	T _{STG}	Storage Temperature	- 65 to +150	°C		

THERMAL DATA

R _{TH(j-c)} Junction-Case Thermal Resistance	2.0	°C/W
---	-----	------

October 7, 1993 rev. 1 1/5

ELECTRICAL SPECIFICATIONS (T_{case} = 25°C)

STATIC

Symbol	Test Conditions	Value			Unit		
		Min.	Тур.	Max.	Unit		
BV _{CBO}	$I_C = 50 \text{mA}$	$I_{E} = 0mA$		48	50		V
BV _{CEO}	I _C = 20mA	$I_B = 0mA$		25	30	_	V
BV _{EBO}	I _E = 5mA	I _C = 0mA		3.5	4.0	_	V
Ісво	V _{CB} = 24V	I _E = 0mA		_	_	1.0	mA
hFE	V _{CE} = 10V	$I_C = 100 \text{mA}$		20	_	100	_

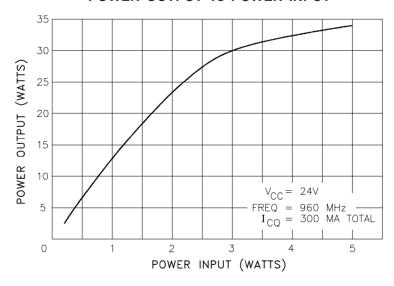
DYNAMIC

Symbol	Test Conditions		Value			Unit	
Symbol	rest Conditions			Min.	Тур.	Max.	Unit
Pout	f = 960 MHz	$P_{IN} = 5.3 W$	$V_{CC} = 24 \text{ V}$	30	_	_	W
G _P	f = 960 MHz	$P_{OUT} = 30 \text{ W}$	$V_{CC} = 24 V$	7.5	_	_	dB
ης	f = 960 MHz	P _{OUT} = 30 W	V _{CC} = 24 V	45	50		%
Сов	f = 1 MHz	V _{CB} = 24 V	(each side)	_	20	24	pF

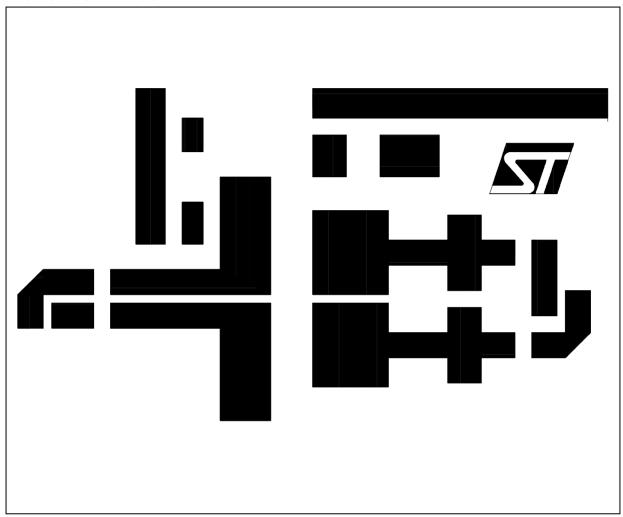
Note: $I_{CQ} = 150 \text{mA}$

TYPICAL PERFORMANCE

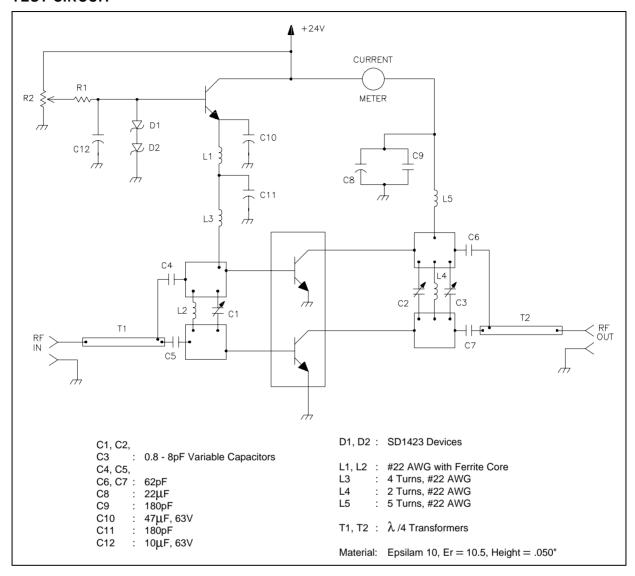
POWER OUTPUT vs POWER INPUT



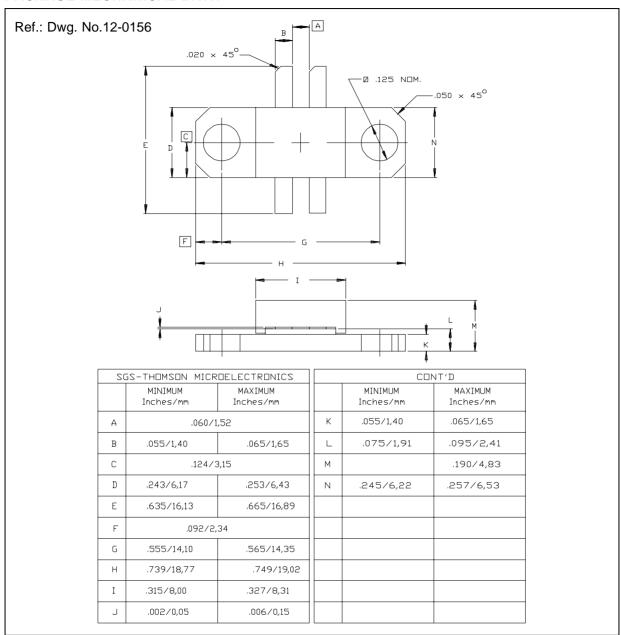
TEST CIRCUIT LAYOUT



TEST CIRCUIT



PACKAGE MECHANICAL DATA



Information furnished is believed to be accurate and reliable. However, SGS-THOMSON Microelectronics assumes no responsability for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may results from its use. No license is granted by implication or otherwise under any patent or patent rights of SGS-THOMSON Microelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. SGS-THOMSON Microelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of SGS-THOMSON Microelectonics.

© 1994 SGS-THOMSON Microelectronics - All Rights Reserved

SGS-THOMSON Microelectronics GROUP OF COMPANIES

Australia - Brazil - France - Germany - Hong Kong - Italy - Japan - Korea - Malaysia - Malta - Morocco - The Netherlands - Singapore - Spain - Sweden - Switzerland - Taiwan - Thailand - United Kingdom - U.S.A

